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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/735,717	12/16/2003	Kiyoshi Kato	0756-7230	5660
31780 7	590 06/06/2006	EXAMINER		
ERIC ROBIN	ISON	PRENTY, MARK V		
PMB 955 21010 SOUTH	IDANIK CT	ART UNIT	PAPER NUMBER	
	ALLS, VA 20165	2822		
•		DATE MAILED: 06/06/2006		

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)				
Interview Summary	10/735,717	KATO, KIYOSHI				
micerview Summary	Examiner	Art Unit				
	MARK PRENTY	2822				
All participants (applicant, applicant's representative, PTO	personnel):					
(1) App. Rep. Robert Pilaud (Reg. No. 53,470).	(3)					
(2) Primary Examiner Mark Prenty.	(4)	·				
Date of Interview: 25 May 2006.						
Type: a)⊠ Telephonic b)□ Video Conference c)□ Personal [copy given to: 1)□ applicant	2) <mark>□ applicant's representative</mark>	e]				
Exhibit shown or demonstration conducted: d) Yes e No. If Yes, brief description:						
Claim(s) discussed: <u>1 and 17</u> .						
Identification of prior art discussed:						
Agreement with respect to the claims f)⊠ was reached. g)□ was not reached. h)□ N/A.						
Substance of Interview including description of the general nature of what was agreed to if an agreement was reached, or any other comments: <u>A proposed Rule 312 amendment was discussed (see attachment)</u> . The examiner indicated it would be entered if filed before or with the payment of the issue fee.						
(A fuller description, if necessary, and a copy of the amendallowable, if available, must be attached. Also, where no callowable is available, a summary thereof must be attached.	copy of the amendments that w					
THE FORMAL WRITTEN REPLY TO THE LAST OFFICE ACTION MUST INCLUDE THE SUBSTANCE OF THE INTERVIEW. (See MPEP Section 713.04). If a reply to the last Office action has already been filed, APPLICANT IS GIVEN A NON-EXTENDABLE PERIOD OF THE LONGER OF ONE MONTH OR THIRTY DAYS FROM THIS INTERVIEW DATE, OR THE MAILING DATE OF THIS INTERVIEW SUMMARY FORM, WHICHEVER IS LATER, TO FILE A STATEMENT OF THE SUBSTANCE OF THE INTERVIEW. See Summary of Record of Interview requirements on reverse side or on attached sheet.						
	V. Prenty y Examiner Examiner's sign	2 Prenty				

Summary of Record of Interview Requirements

Manual of Patent Examining Procedure (MPEP), Section 713.04, Substance of Interview Must be Made of Record

A complete written statement as to the substance of any face-to-face, video conference, or telephone interview with regard to an application must be made of record in the application whether or not an agreement with the examiner was reached at the interview.

Title 37 Code of Federal Regulations (CFR) § 1.133 Interviews

Paragraph (b)

In every instance where reconsideration is requested in view of an interview with an examiner, a complete written statement of the reasons presented at the interview as warranting favorable action must be filed by the applicant. An interview does not remove the necessity for reply to Office action as specified in §§ 1.111, 1.135. (35 U.S.C. 132)

37 CFR §1.2 Business to be transacted in writing.

All business with the Patent or Trademark Office should be transacted in writing. The personal attendance of applicants or their attorneys or agents at the Patent and Trademark Office is unnecessary. The action of the Patent and Trademark Office will be based exclusively on the written record in the Office. No attention will be paid to any alleged oral promise, stipulation, or understanding in relation to which there is disagreement or doubt.

The action of the Patent and Trademark Office cannot be based exclusively on the written record in the Office if that record is itself incomplete through the failure to record the substance of interviews.

It is the responsibility of the applicant or the attorney or agent to make the substance of an interview of record in the application file, unless the examiner indicates he or she will do so. It is the examiner's responsibility to see that such a record is made and to correct material inaccuracies which bear directly on the question of patentability.

Examiners must complete an Interview Summary Form for each interview held where a matter of substance has been discussed during the interview by checking the appropriate boxes and filling in the blanks. Discussions regarding only procedural matters, directed solely to restriction requirements for which interview recordation is otherwise provided for in Section 812.01 of the Manual of Patent Examining Procedure, or pointing out typographical errors or unreadable script in Office actions or the like, are excluded from the interview recordation procedures below. Where the substance of an interview is completely recorded in an Examiners Amendment, no separate Interview Summary Record is required.

The Interview Summary Form shall be given an appropriate Paper No., placed in the right hand portion of the file, and listed on the "Contents" section of the file wrapper. In a personal interview, a duplicate of the Form is given to the applicant (or attorney or agent) at the conclusion of the interview. In the case of a telephone or video-conference interview, the copy is mailed to the applicant's correspondence address either with or prior to the next official communication. If additional correspondence from the examiner is not likely before an allowance or if other circumstances dictate, the Form should be mailed promptly after the interview rather than with the next official communication.

The Form provides for recordation of the following information:

- Application Number (Series Code and Serial Number)
- Name of applicant
- Name of examiner
- Date of interview
- Type of interview (telephonic, video-conference, or personal)
- Name of participant(s) (applicant, attorney or agent, examiner, other PTO personnel, etc.)
- An indication whether or not an exhibit was shown or a demonstration conducted
- An identification of the specific prior art discussed
- An indication whether an agreement was reached and if so, a description of the general nature of the agreement (may be by
 attachment of a copy of amendments or claims agreed as being allowable). Note: Agreement as to allowability is tentative and does
 not restrict further action by the examiner to the contrary.
- The signature of the examiner who conducted the interview (if Form is not an attachment to a signed Office action)

It is desirable that the examiner orally remind the applicant of his or her obligation to record the substance of the interview of each case. It should be noted, however, that the Interview Summary Form will not normally be considered a complete and proper recordation of the interview unless it includes, or is supplemented by the applicant or the examiner to include, all of the applicable items required below concerning the substance of the interview.

A complete and proper recordation of the substance of any interview should include at least the following applicable items:

- 1) A brief description of the nature of any exhibit shown or any demonstration conducted,
- 2) an identification of the claims discussed,
- 3) an identification of the specific prior art discussed,
- 4) an identification of the principal proposed amendments of a substantive nature discussed, unless these are already described on the Interview Summary Form completed by the Examiner.
- 5) a brief identification of the general thrust of the principal arguments presented to the examiner,

(The identification of arguments need not be lengthy or elaborate. A verbatim or highly detailed description of the arguments is not required. The identification of the arguments is sufficient if the general nature or thrust of the principal arguments made to the examiner can be understood in the context of the application file. Of course, the applicant may desire to emphasize and fully describe those arguments which he or she feels were or might be persuasive to the examiner.)

- 6) a general indication of any other pertinent matters discussed, and
- 7) if appropriate, the general results or outcome of the interview unless already described in the Interview Summary Form completed by the examiner.

Examiners are expected to carefully review the applicant's record of the substance of an interview. If the record is not complete and accurate, the examiner will give the applicant an extendable one month time period to correct the record.

Examiner to Check for Accuracy

If the claims are allowable for other reasons of record, the examiner should send a letter setting forth the examiner's version of the statement attributed to him or her. If the record is complete and accurate, the examiner should place the indication, "Interview Record OK" on the paper recording the substance of the interview along with the date and the examiner's initials.

IIIRIPLO:

ROBINSON INTELLECTUAL PROPERTY LAW OFFICE

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May 25, 2006

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FACSIMILE COVER SHEET

То:	Examiner Pre	nty		L. Pilaud, Reg. No. 53,470
Facsimile Number: 571-273-1843		Telephone No.	571-272-1843	
Number of Pages (including cover sheet):			2	

In re Patent Application of:

Kiyoshi KATO

Serial No. 10/735,717

Filed: December 16, 2003

For: SEMICONDUCTOR MEMORY ELEMENT, SEMICONDUCTOR MEMORY

DEVICE AND METHOD OF FABRICATING THE SAME

Docket No.: 0756-7230

Mr. Prenty,

Thanks again for your time and attention to this matter. Per our discussion, attached is a proposed Rule 312 Amendment of claims 1 and 17. Claim 1 is the same as previously proposed. In claim 17, the Applicant is concerned that the claim recites both "wherein the channel region is a crystallized polycrystal semiconductor film" and "wherein the semiconductor active layer is a polycrystal semiconductor film." Since the channel region is part of the active layer, claim 17 is potentially unclear. The Applicant seeks to correct this matter by amending claim 17 to more clearly recite that "the semiconductor active layer is a crystallized polycrystal semiconductor film." The proposed amendments are believed to be needed for proper disclosure or protection of the invention, and are not believed to require a substantial amount of additional work on the part of the Office. The proposed amendments are not believed to add new matter. If possible, once you have had an opportunity to review these proposed changes, please give me a call so we may discuss in greater detail.

Sincerely,

Rob Pilaud

- -2-Application Serial No. 10/735,717 Attorney Docket No. 0756-7230
- (Currently Amended) A semiconductor memory element comprising a semiconductor active layer comprising a channel region and one conductive type impurity region, a first gate insulating film, a charge accumulating layer, a second gate insulating film, and a control gate electrode,

wherein the semiconductor memory element is formed over a substrate having an insulating surface;

wherein the semiconductor active layer is a polycrystal semiconductor film:

wherein a grain boundary of a crystal grain in the polycrystal semiconductor film is flat or formed with a recessed portion; and

wherein a surface roughness of the channel region is 0.1 nm through 60 nm in a P-V value.

17. (Currently Amended) A semiconductor memory element comprising a semiconductor active layer comprising a channel region and one conductive type impurity region, a first gate insulating film, a charge accumulating layer, a second gate insulating film, and a control gate electrode,

wherein the semiconductor memory element is formed over a substrate having an insulating surface;

wherein the channel region is a crystallized-polycrystal semiconductor film;

wherein the semiconductor active layer is a crystallized polycrystal semiconductor film;

wherein the semiconductor active layer is constituted by aggregating a plurality of crystal grains elongated in the same direction; and

wherein a grain boundary of a crystal grain in the polycrystal semiconductor film is flat or formed with a recessed portion.